

Mohamed Labeled

List of Publications by Year in descending order

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Version: 2024-02-01

2
papers

18
citations

2682572

2
h-index

2917675

2
g-index

2
all docs

2
docs citations

2
times ranked

22
citing authors

#	ARTICLE	IF	CITATIONS
1	Numerical Simulation on Thickness Dependency and Bias Stress Test of Ultrathin IGZO Thin-Film Transistors Via a Solution Process. <i>Physica Status Solidi (A) Applications and Materials Science</i> , 2019, 216, 1800987.	1.8	7
2	Simulation of the influence of the gate dielectric on amorphous indium-gallium-zinc oxide thin-film transistor reliability. <i>Journal of Computational Electronics</i> , 2019, 18, 509-518.	2.5	11